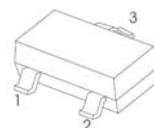


SOT-23 Plastic-Encapsulate MOSFETS

N-Channel MOSFET

V_{(BR)DSS}	R_{DS(on)MAX}	I_D
20 V	350m Ω@ 4.5V	0.8A
	450mΩ@ 2.5V	
	800mΩ@1.8V	

SOT-23



1. GATE
2. SOURCE
3. DRAIN

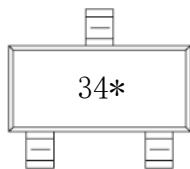
FEATURES

- ⌘ Lead Free Product is Acquired
- ⌘ Surface Mount Package
- ⌘ N-Channel Switch with Low R_{DS(on)}
- ⌘ Operated at Low Logic Level Gate Drive

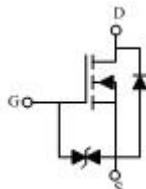
APPLICATION

- ⌘ Load/Power Switching
- ⌘ Interfacing Switching
- ⌘ Battery Management for Ultra Small Portable Electronics
- ⌘ Logic Level Shift

MARKING



Equivalent Circuit



Maximum ratings (T_a=25°C unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V _{DS}	20	V
Typical Gate-Source Voltage	V _{GS}	±10	V
Continuous Drain Current (note 1)	I _D	0.8	A
Pulsed Drain Current (t _p =10μs)	I _{DM}	1.8	A
Power Dissipation (note 1)	P _D	350	mW
Thermal Resistance from Junction to Ambient (note 1)	R _{θJA}	357	°C/W
Operation Junction and Storage Temperature Range	T _{J,T_{STG}}	-55~+150	°C
Lead Temperature for Soldering Purposes(1/8" duration for 10 s)	T _L	260	°C

MOSFET ELECTRICAL CHARACTERISTICS

$T_a=25^\circ\text{C}$ unless otherwise specified

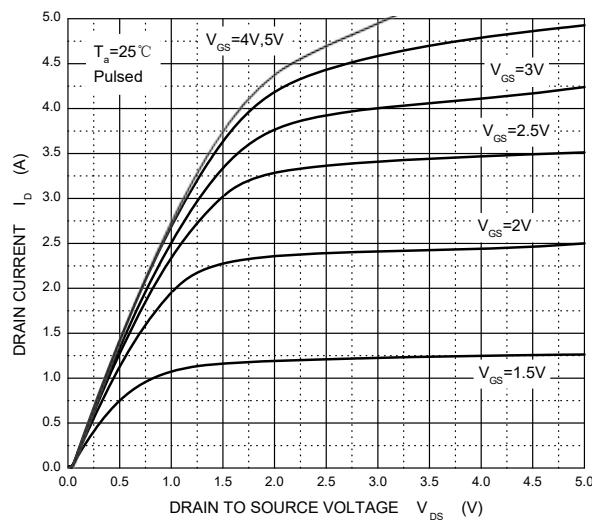
Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
STATIC CHARACTERISTICS						
Drain-source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	20			V
Zero gate voltage drain current	I_{DSS}	$V_{\text{DS}} = 20\text{V}, V_{\text{GS}} = 0\text{V}$			1	μA
Gate-body leakage current	I_{GSS}	$V_{\text{GS}} = \pm 10\text{V}, V_{\text{DS}} = 0\text{V}$			± 20	μA
Gate threshold voltage (note 2)	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	0.4	0.65	1.0	V
Drain-source on-resistance (note 2)	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 4.5\text{V}, I_D = 0.65\text{A}$		270	350	$\text{m}\Omega$
		$V_{\text{GS}} = 2.5\text{V}, I_D = 0.55\text{A}$		320	450	$\text{m}\Omega$
		$V_{\text{GS}} = 1.8\text{V}, I_D = 0.45\text{A}$		390	800	$\text{m}\Omega$
Forward transconductance (note 2)	g_{FS}	$V_{\text{DS}} = 10\text{V}, I_D = 0.8\text{A}$		1.6		S
Diode forward voltage	V_{SD}	$I_S = 0.15\text{A}, V_{\text{GS}} = 0\text{V}$			1.2	V
DYNAMIC CHARACTERISTICS (note 4)						
Input capacitance	C_{iss}	$V_{\text{DS}} = 16\text{V}, V_{\text{GS}} = 0\text{V}, f = 1\text{MHz}$		79	120	pF
Output capacitance	C_{oss}			13	20	pF
Reverse transfer capacitance	C_{rss}			9	15	pF
SWITCHING CHARACTERISTICS (note 4)						
Turn-on delay time (note 3)	$t_{\text{d}(\text{on})}$	$V_{\text{GS}} = 4.5\text{V}, V_{\text{DS}} = 10\text{V}, I_D = 500\text{mA}, R_{\text{GEN}} = 10\Omega$		6.7		ns
Turn-on rise time (note 3)	t_r			4.8		ns
Turn-off delay time (note 3)	$t_{\text{d}(\text{off})}$			17.3		ns
Turn-off fall time (note 3)	t_f			7.4		ns

Notes :

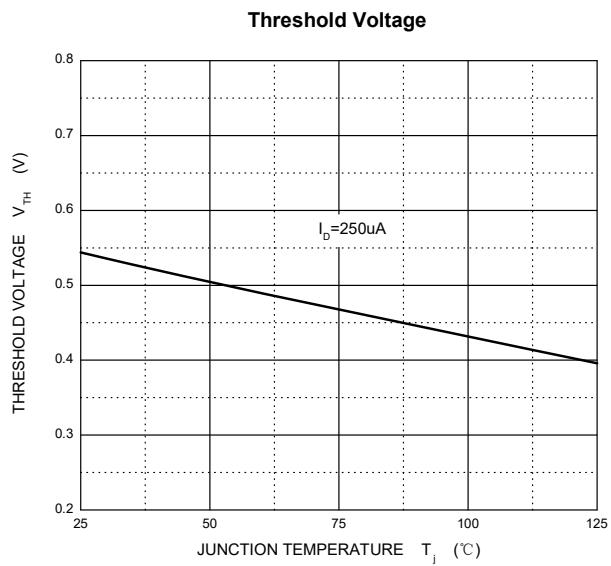
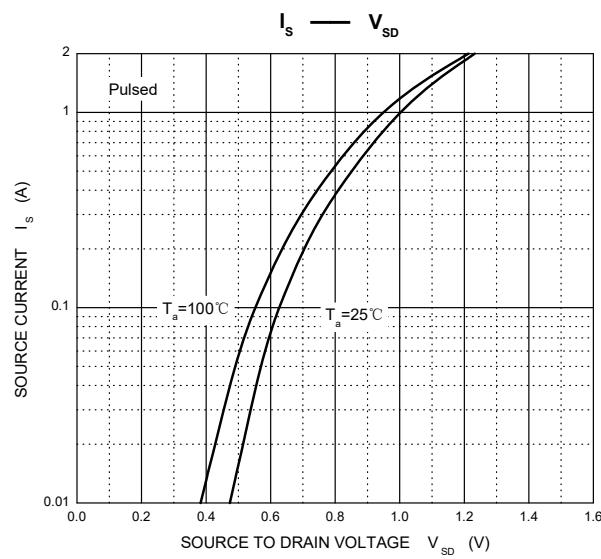
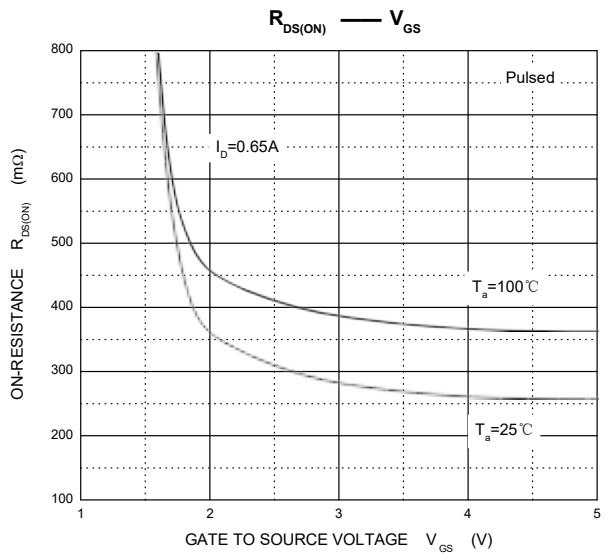
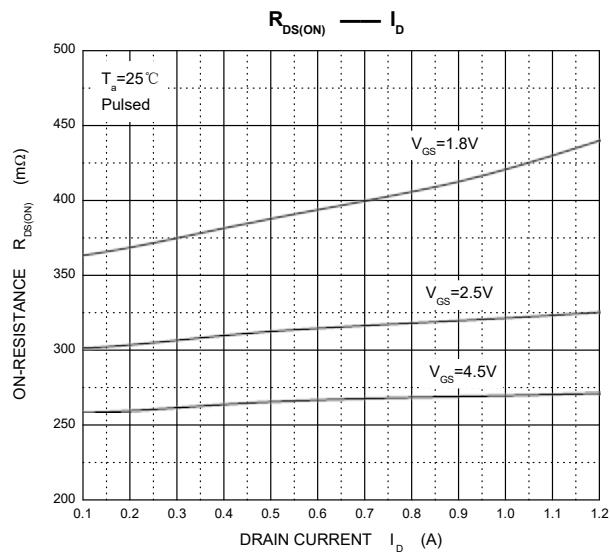
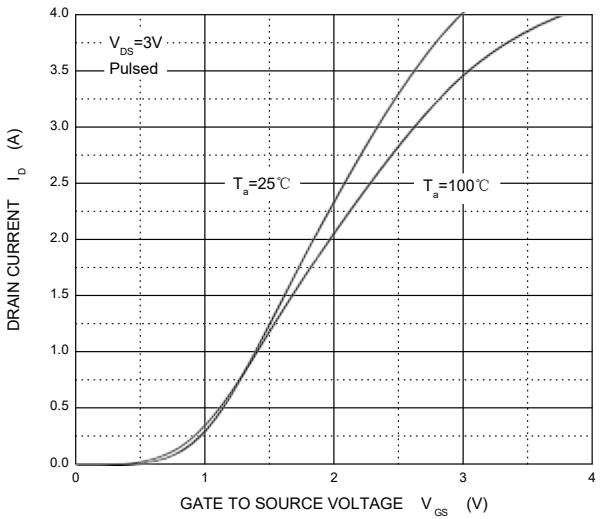
1. Surface mounted on FR4 board using the minimum recommended pad size.
2. Pulse Test : Pulse Width=300 μs , Duty Cycle=2%.
3. Switching characteristics are independent of operating junction temperatures.
4. Guaranteed by design, not subject to producting.

Typical Characteristics

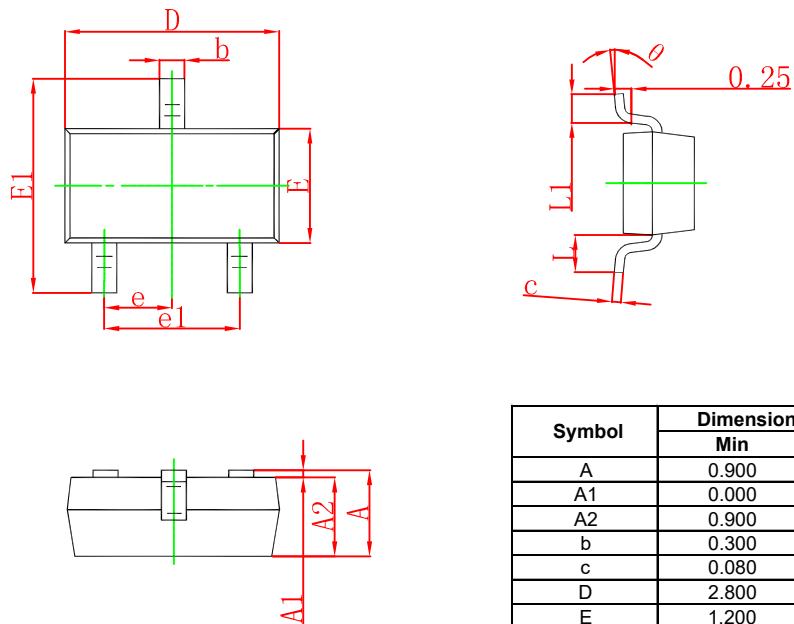
Output Characteristics



Transfer Characteristics

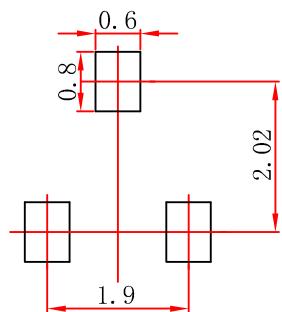


SOT-23 Package Outline Dimensions



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950 TYP		0.037 TYP	
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022 REF	
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

SOT-23 Suggested Pad Layout



Note:

1. Controlling dimension: in millimeters.
2. General tolerance: $\pm 0.05\text{mm}$.
3. The pad layout is for reference purposes only.